Notice of References Cited Application/Control No. 10/642,256 Examiner Roderick Tolentino Applicant(s)/Patent Under Reexamination YUAN, WEI Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	, A	US-2003/0212764	11-2003	Trossen et al.	709/219
*	В	US-2003/0212809	11-2003	Wu et al.	709/231
*	Ç	US-6,941,477	09-2005	O'Keefe, Kevin	726/4
	D	US-			
	E	US-			
	F	US-			•
	G	US-			
H	Н	US-			
		US-			·
	J	US-		·	
	К	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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NON-PATENT DOCUMENTS

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*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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